N-channel TrenchMOS standard level FET

Rev. 02 — 25 February 2010

Product data sheet

Low conduction losses due to low

Switched-mode power supplies

on-state resistance

1. Product profile

1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product is designed and qualified for use in computing, communications, consumer and industrial applications only.

1.2 Features and benefits

 Higher operating power due to low thermal resistance

1.3 Applications

DC-to-DC convertors

1.4 Quick reference data

Symbol Parameter Conditions Min Тур Max Unit drain-source voltage $T_i \ge 25 \text{ °C}; T_i \le 175 \text{ °C}$ V V_{DS} 110 _ drain current $T_{mb} = 25 \text{ °C}; V_{GS} = 10 \text{ V};$ 23 А I_D see Figure 1 and 3 W P_{tot} total power T_{mb} = 25 °C; see Figure 2 100 _ dissipation **Dynamic characteristics** V_{GS} = 10 V; I_D = 23 A; 10 nC Q_{GD} gate-drain charge _ -V_{DS} = 80 V; T_i = 25 °C; see Figure 11 **Static characteristics** V_{GS} = 10 V; I_D = 13 A; T_i = 25 °C; 49 70 mΩ R_{DSon} drain-source see Figure 9 and 10 on-state resistance

Table 1. Quick reference



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2. Pinning information

Table 2.	Pinning	information				
Pin	Symbol	Description	Simplified outline	Graphic symbol		
1	G	gate		_		
2	D	drain	mb			
3	S	source				
mb	D	mounting base; connected to drain		mbb076 S		

SOT78 (TO-220AB)

3. Ordering information

Table 3. Ordering information

Type number	Package				
	Name	Description	Version		
PHP23NQ11T	TO-220AB	plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB	SOT78		

4. Limiting values

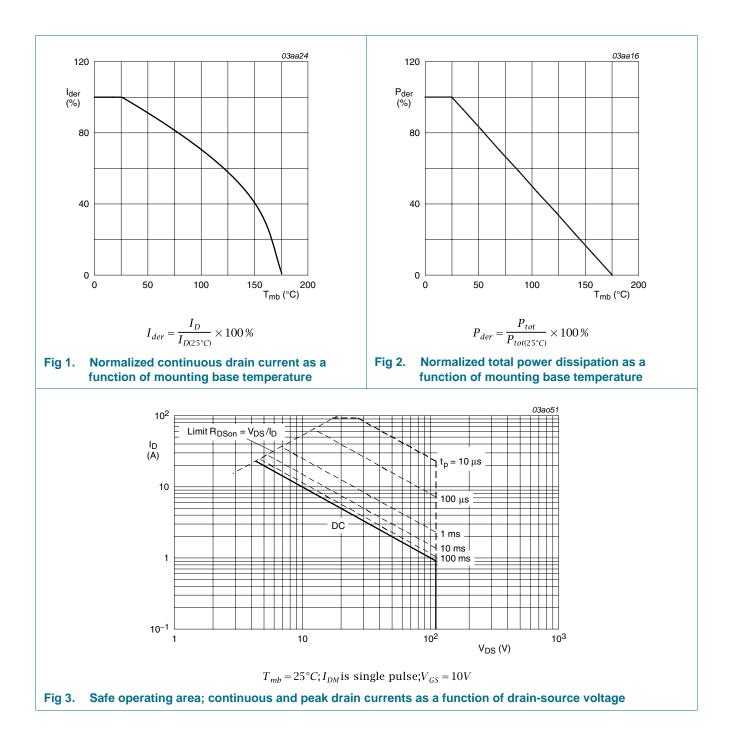
Table 4.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Мах	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	-	110	V
V _{DGR}	drain-gate voltage	T _j ≥ 25 °C; T _j ≤ 175 °C; R _{GS} = 20 kΩ	-	110	V
V _{GS}	gate-source voltage		-20	20	V
I _D	drain current	$V_{GS} = 10 \text{ V}; \text{ T}_{mb} = 100 \text{ °C}; \text{ see } \frac{\text{Figure 1}}{100 \text{ Figure 1}}$	-	16	А
		V_{GS} = 10 V; T_{mb} = 25 °C; see <u>Figure 1</u> and <u>3</u>	-	23	А
I _{DM}	peak drain current	$t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$; see Figure 3	-	92	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	100	W
T _{stg}	storage temperature		-55	175	°C
Tj	junction temperature		-55	175	°C
Source-dr	ain diode				
I _S	source current	T _{mb} = 25 °C	-	23	А
I _{SM}	peak source current	$t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$	-	92	А
Avalanche	e ruggedness				
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 14 A; V_{sup} ≤ 100 V; unclamped; t_p = 0.1 ms; R_{GS} = 50 Ω	-	93	mJ
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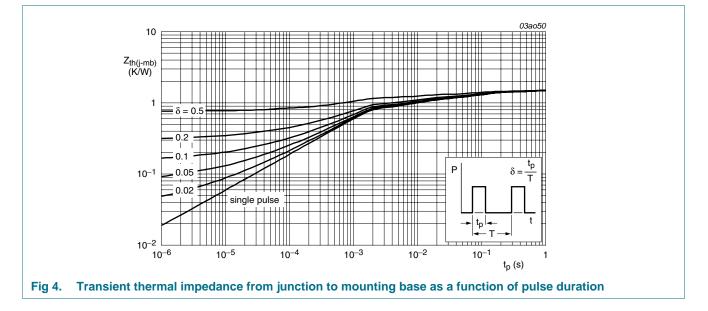
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Thermal characteristics 5.

Table 5.	I hermal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	see Figure 4	-	-	1.5	K/W
R _{th(j-a)}	thermal resistance from junction to ambie	nt vertical in still air	-	60	-	K/W

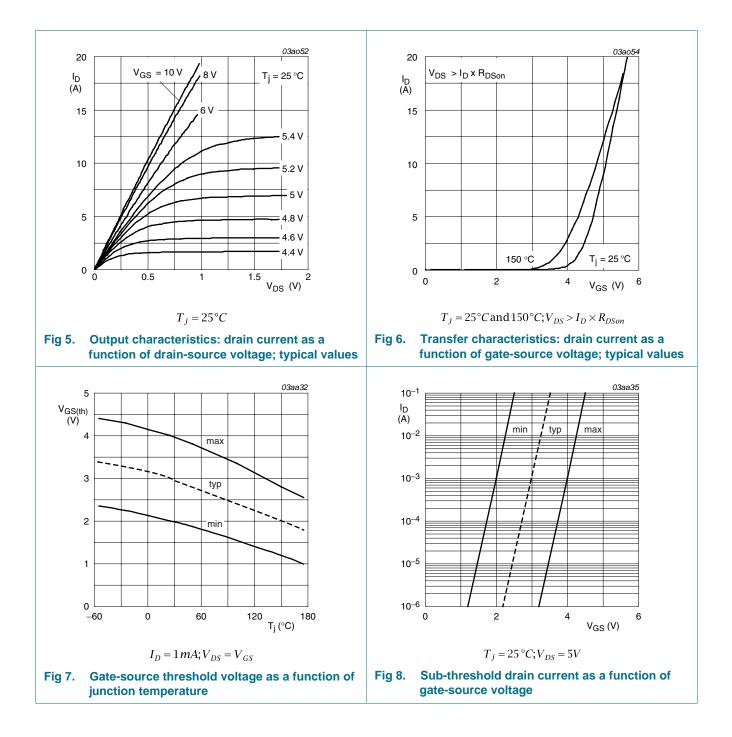


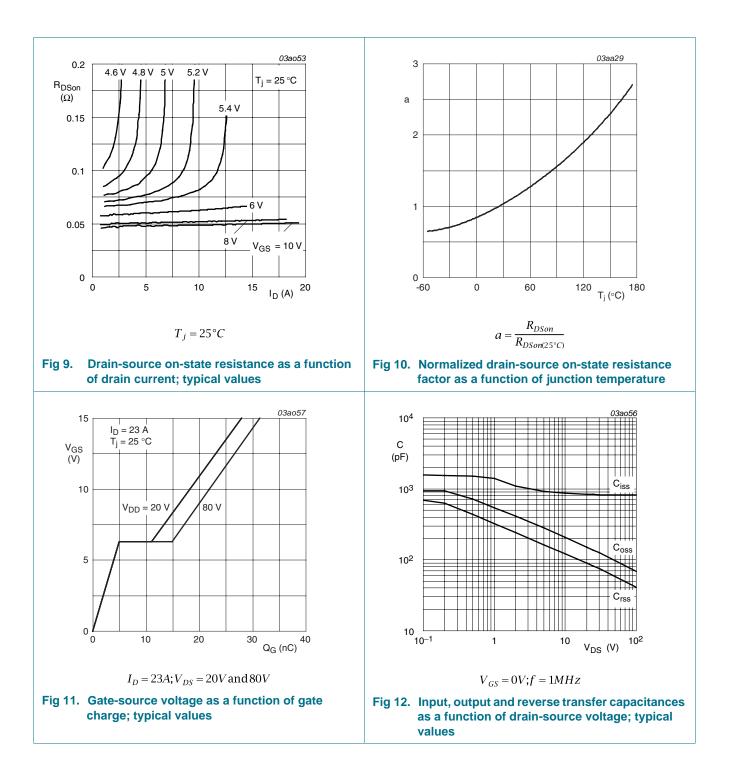
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6. Characteristics

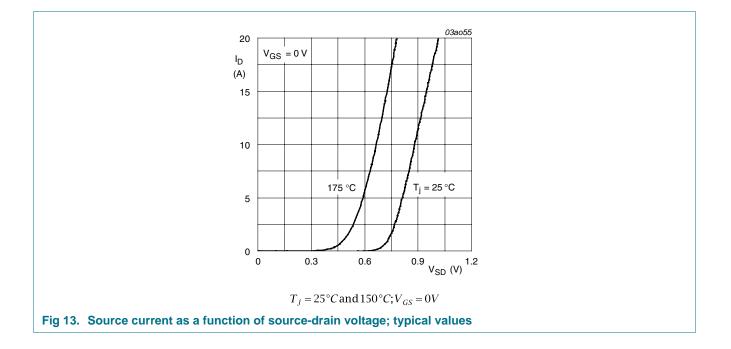
Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
V _{(BR)DSS}	drain-source	$I_D = 250 \ \mu A; \ V_{GS} = 0 \ V; \ T_j = 25 \ ^\circ C$	110	-	-	V
	breakdown voltage	$I_D = 250 \ \mu A; \ V_{GS} = 0 \ V; \ T_j = -55 \ ^\circ C$	99	-	-	V
V _{GS(th)}	gate-source threshold voltage	I_D = 1 mA; V_{DS} = V_{GS} ; T_j = 25 °C; see <u>Figure 7</u> and <u>8</u>	2	3	4	V
		I_D = 1 mA; V_{DS} = V_{GS} ; T_j = -55 °C; see <u>Figure 7</u> and <u>8</u>	-	-	4.4	V
		I_D = 1 mA; V_{DS} = V_{GS} ; T_j = 175 °C; see Figure 7 and 8	1	-	-	V
I _{DSS}	drain leakage current	$V_{DS} = 100 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-	10	μA
		V_{DS} = 100 V; V_{GS} = 0 V; T_j = 175 °C	-	-	500	μA
I _{GSS}	gate leakage current	V_{GS} = 10 V; V_{DS} = 0 V; T_j = 25 °C	-	10	100	nA
		$V_{GS} = -10 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C}$	-	10	100	nA
R _{DSon}	drain-source on-state resistance	V_{GS} = 10 V; I _D = 13 A; T _j = 175 °C; see <u>Figure 9</u> and <u>10</u>	-	132	189	mΩ
		V_{GS} = 10 V; I_{D} = 13 A; T_{j} = 25 °C; see Figure 9 and $\underline{10}$	-	49	70	mΩ
Dynamic	characteristics					
Q _{G(tot)}	total gate charge	$I_D = 23 \text{ A}; V_{DS} = 80 \text{ V}; V_{GS} = 10 \text{ V}; T_j = 25 \text{ °C};$	-	22	-	nC
Q _{GS}	gate-source charge	see Figure 11	-	5	-	nC
Q _{GD}	gate-drain charge		-	10	-	nC
C _{iss}	input capacitance	$V_{DS} = 25 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}; T_j = 25 \text{ °C};$	-	830	-	pF
C _{oss}	output capacitance	see Figure 12	-	140	-	pF
C _{rss}	reverse transfer capacitance		-	85	-	pF
t _{d(on)}	turn-on delay time	V_{DS} = 50 V; R_L = 2.2 $\Omega;$ V_{GS} = 10 V;	-	8	-	ns
t _r	rise time	$R_{G(ext)} = 5.6 \Omega; T_j = 25 \ ^{\circ}C$	-	39	-	ns
t _{d(off)}	turn-off delay time		-	26	-	ns
t _f	fall time		-	24	-	ns
Source-d	rain diode					
V _{SD}	source-drain voltage	$I_S = 11 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure } 13}{100000000000000000000000000000000000$	-	0.9	1.5	V
t _{rr}	reverse recovery time	$I_{S} = 11 \text{ A}; \text{ d}I_{S}/\text{d}t = -100 \text{ A}/\mu\text{s}; \text{ V}_{GS} = 0 \text{ V};$	-	64	-	ns
Qr	recovered charge	V _{DS} = 25 V; T _j = 25 °C	-	120	-	nC





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7. Package outline

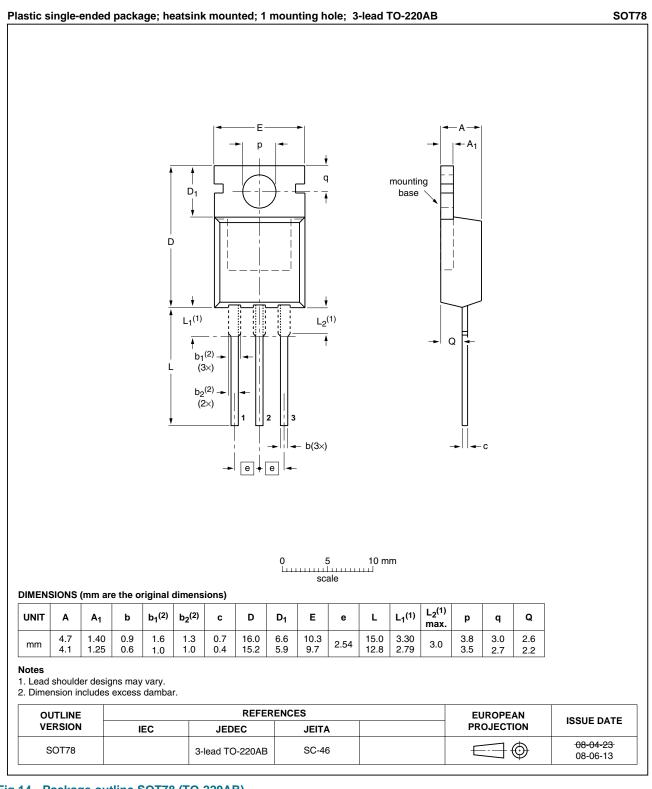


Fig 14. Package outline SOT78 (TO-220AB)

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8. Revision history

on history			
Release date	Data sheet status	Change notice	Supersedes
20100225	Product data sheet	-	PHP23NQ11T_1
		• .	ly with the new identity
 Legal texts 	have been adapted to	the new company name v	where appropriate.
20040517	Product data	-	-
	20100225 • The format guidelines of • Legal texts	Release date Data sheet status 20100225 Product data sheet • The format of this data sheet has beguidelines of NXP Semiconductors • Legal texts have been adapted to the semiconduct of the semiconduct of the semiconductors	Release date Data sheet status Change notice 20100225 Product data sheet - • The format of this data sheet has been redesigned to comp guidelines of NXP Semiconductors. - • Legal texts have been adapted to the new company name of

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9.1 Data sheet status

Document status [1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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